Notice of References Cited

Application/Control No.

Applicant(s)/Patent Under Reexamination CHEN ET AL.

Examiner

Linh Truong

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,279,854	01-1994	Kendall et al.	427/197
	В	US-5,843,059	12-1998	Niemeyer et al.	604/368
	С	US-6,495,734	12-2002	Fields et al.	604/378
	D	US-6,521,087	02-2003	Hansen et al.	162/173
	Е	US-2003/0105441	06-2003	Chmielewski, Harry J.	604/368
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			•
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	a					
	R					
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	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
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	w		
	х		

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.